

Notice of References Cited	Application/Control No. 10/026,429	Applicant(s)/Patent Under Reexamination OKAJIMA, AIKO	
	Examiner CHAN S. PARK	Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,930,796	08-2005	Matsuura et al.	358/1.2
	B	US-			
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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